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|-----------------------------------|--|-------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/722,461 | TAKAHASHI ET AL. | |
| | | Examiner | Art Unit | Page 1 of 1 |
| | | Son L. Mai | 2827 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-5,376,814 A | 12-1994 | Lee, Yong H. | 257/334 |
| | B | US-5,398,200 A | 03-1995 | Mazure et al. | 365/174 |
| | C | US-5,453,949 A | 09-1995 | Wiedmann et al. | 365/156 |
| | D | US-5,670,803 A | 09-1997 | Beilstein et al. | 257/278 |
| | E | US-6,483,739 B2 | 11-2002 | Houston, Theodore W. | 365/154 |
| | F | US-6,903,411 B1 | 06-2005 | Chyan et al. | 257/329 |
| | G | US-6,442,060 B1 | 08-2002 | Leung et al. | 365/154 |
| | H | US-6,584,030 B2 | 06-2003 | Marr, Kenneth W. | 365/226 |
| | I | US-6,434,040 B1 | 08-2002 | Kim et al. | 365/154 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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